



**Advanced Power
Electronics Corp.**

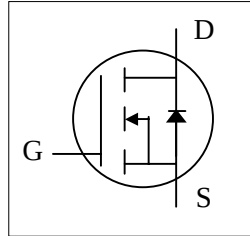
AP3N2R8AMT

Halogen-Free Product

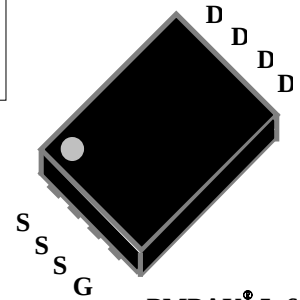
N-CHANNEL MOSFET WITH SCHOTTKY

DIODE

- ▼ 100% R_g & UIS Test
- ▼ Simple Drive Requirement
- ▼ Ultra Low On-resistance
- ▼ RoHS Compliant & Halogen-Free



BV_{DSS}	30V
$R_{DS(ON)}$	2.8m Ω



PMPAK[®] 5x6

Description

AP3N2R8A series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The PMPAK[®] 5x6 package is special for DC-DC converters application and the foot print is compatible with SO-8 with backside heat sink and lower profile.

Absolute Maximum Ratings@ $T_j=25^{\circ}\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D@T_C=25^{\circ}\text{C}$	Drain Current, V_{GS} @ 10V ⁴ (Silicon Limited)	103	A
$I_D@T_C=25^{\circ}\text{C}$	Drain Current, V_{GS} @ 10V ⁴ (Package Limited)	60	A
$I_D@T_A=25^{\circ}\text{C}$	Drain Current, V_{GS} @ 10V ³	32.8	A
$I_D@T_A=70^{\circ}\text{C}$	Drain Current, V_{GS} @ 10V ³	26.2	A
I_{DM}	Pulsed Drain Current ¹	240	A
$P_D@T_C=25^{\circ}\text{C}$	Total Power Dissipation	50	W
$P_D@T_A=25^{\circ}\text{C}$	Total Power Dissipation ³	5	W
E_{AS}	Single Pulse Avalanche Energy ⁵	80	mJ
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}\text{C}$

Thermal Data

Symbol	Parameter	Value	Unit
Rthj-c	Maximum Thermal Resistance, Junction-case	2.5	$^{\circ}\text{C}/\text{W}$
Rthj-a	Maximum Thermal Resistance, Junction-ambient ³	25	$^{\circ}\text{C}/\text{W}$



AP3N2R8AMT

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	30	-	-	V
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =20A	-	-	2.8	mΩ
		V _{GS} =4.5V, I _D =12A	-	-	4.2	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	-	3	V
g _{fs}	Forward Transconductance	V _{DS} =5V, I _D =20A	-	84	-	S
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V, V _{GS} =0V	-	-	10	uA
I _{GSS}	Gate-Source Leakage	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Q _g	Total Gate Charge	I _D =20A	-	25	40	nC
Q _{gs}	Gate-Source Charge	V _{DS} =15V	-	7	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =4.5V	-	11	-	nC
t _{d(on)}	Turn-on Delay Time	V _{DS} =15V	-	18	-	ns
t _r	Rise Time	I _D =1A	-	9	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =3.3Ω	-	43	-	ns
t _f	Fall Time	V _{GS} =10V	-	22	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	2550	4080	pF
C _{oss}	Output Capacitance	V _{DS} =15V	-	475	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	280	-	pF
R _g	Gate Resistance	f=1.0MHz	-	2	4	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =20A, V _{GS} =0V	-	-	1.2	V
t _{rr}	Reverse Recovery Time	I _S =20A, V _{GS} =0V,	-	14	-	ns
Q _{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	4.5	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in² copper pad of FR4 board, t ≤10sec ; 60°C/W at steady state.
- 4.Package limitation current is 60A .
- 5.Starting T_j=25°C , V_{DD}=30V , L=0.1mH , R_G=25Ω , V_{GS}=10V

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

APEC DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

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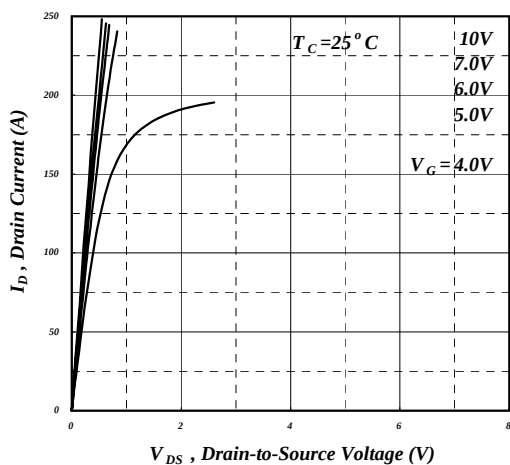


Fig 1. Typical Output Characteristics

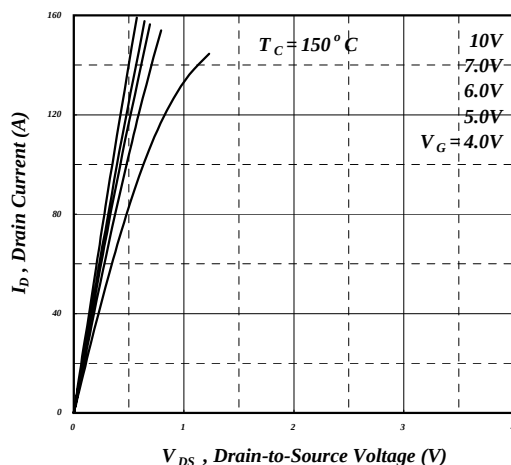


Fig 2. Typical Output Characteristics

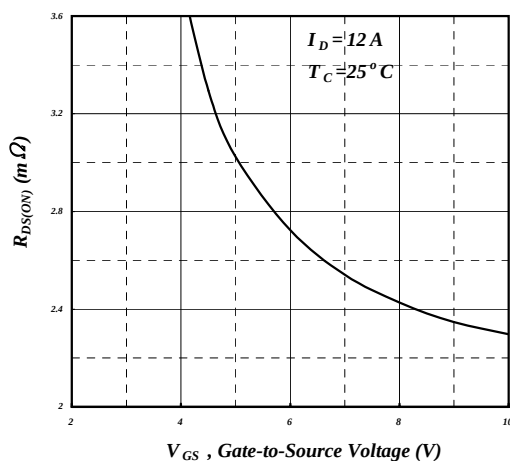


Fig 3. On-Resistance v.s. Gate Voltage

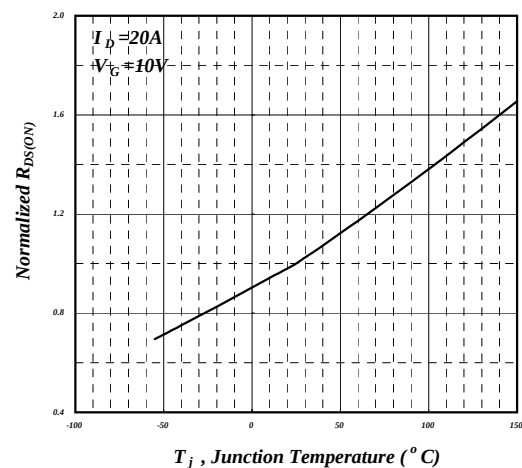


Fig 4. Normalized On-Resistance v.s. Junction Temperature

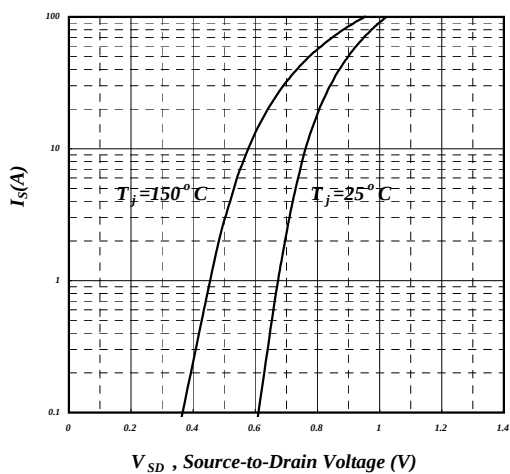


Fig 5. Forward Characteristic of Reverse Diode

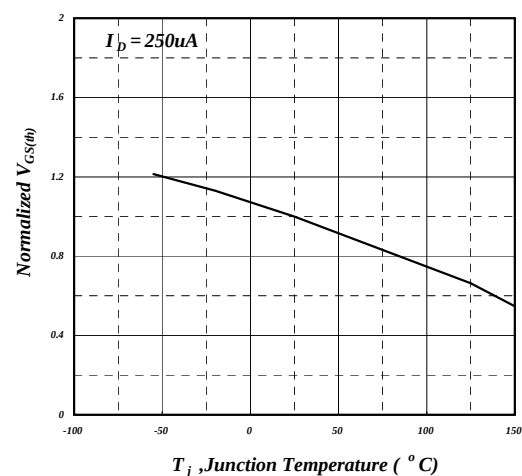


Fig 6. Transfer Characteristics

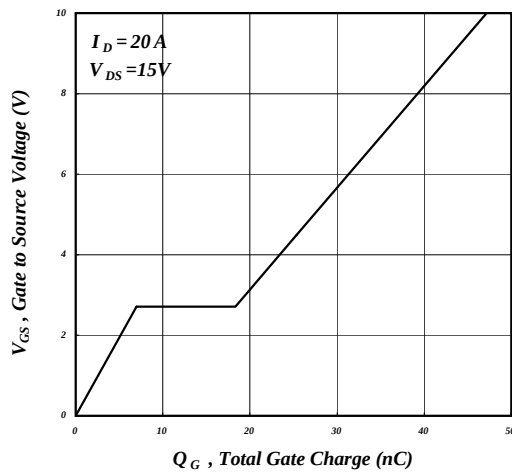


Fig 7. Gate Charge Characteristics

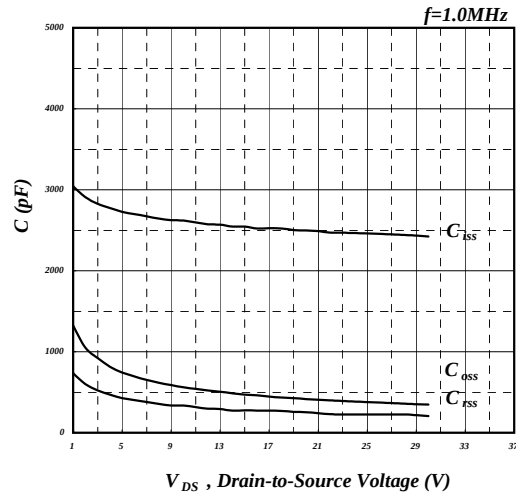


Fig 8. Typical Capacitance Characteristics

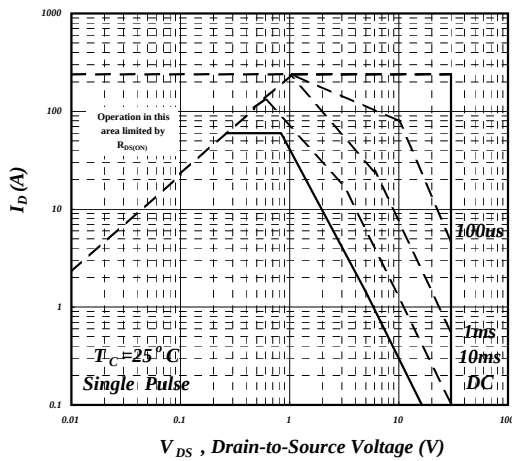


Fig 9. Maximum Safe Operating Area

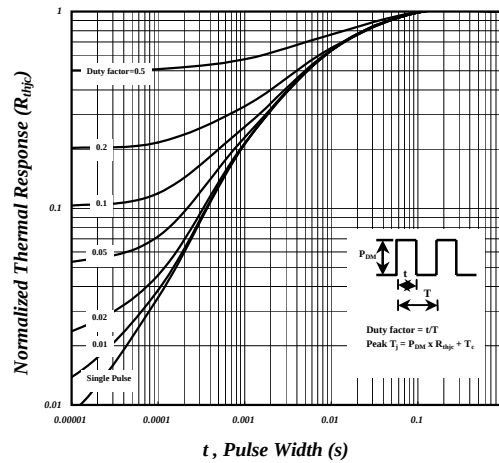


Fig 10. Effective Transient Thermal Impedance

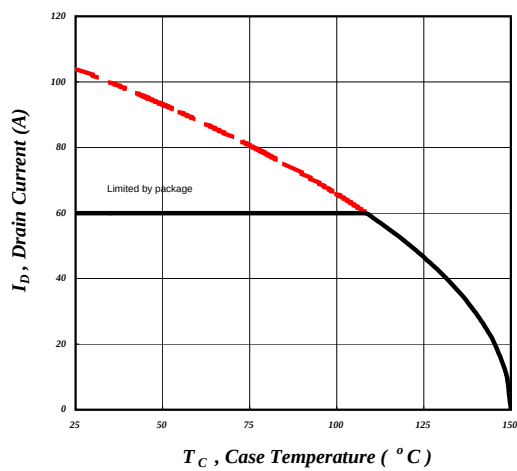


Fig 11. Drain Current v.s. Case Temperature

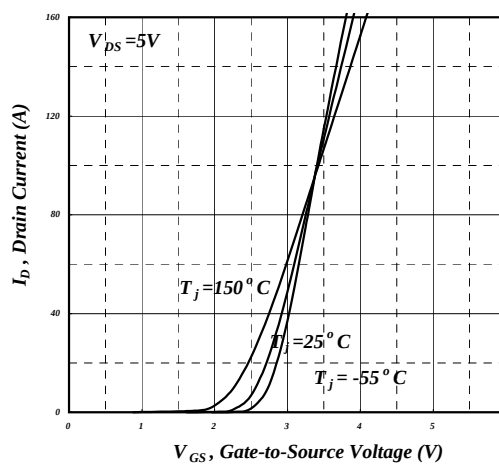


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

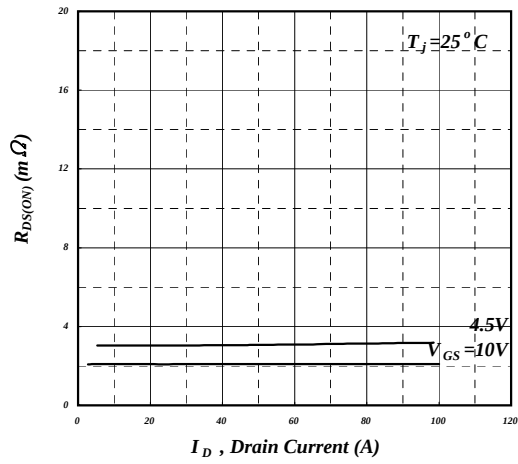


Fig 13. Typ. Drain-Source on State Resistance

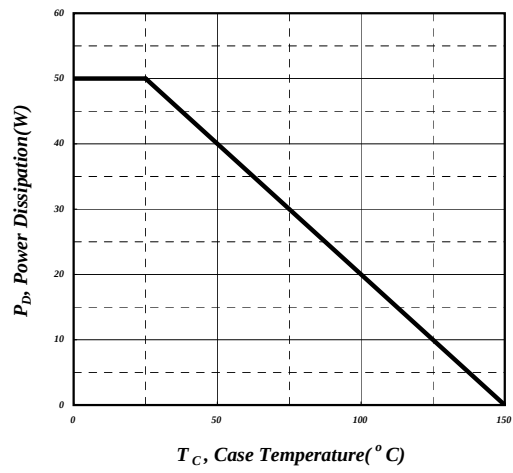


Fig 14. Total Power Dissipation



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MARKING INFORMATION

